

Search Notes

Application/Control No.

10/522,686

Examiner

Jinhee J. Lee

Applicant(s)/Patent under
Reexamination

KIKUCHI ET AL.

Art Unit

2831

SEARCHED

Class	Subclass	Date	Examiner
174	135, 33, 32, 350, 354, 360	10/2/2006	LEE
↓	363, 368	↓	↓
↓	377, 390	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
174	as above	10/2/2006	LEE

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east search attached	10/2/2003	LEE